

Spread Spectrum Frequency Timing Generator

Features

- Maximized EMI suppression using Cypress's Spread Spectrum technology
- Generates a spread spectrum copy of the provided input
- Selectable spreading characteristics
- · Integrated loop filter components
- Operates with a 3.3V or 5V supply
- SSON# pin enables frequency spreading
- Low power CMOS design
- Available in 8-pin SOIC (Small Outline Integrated Circuit)

Overview

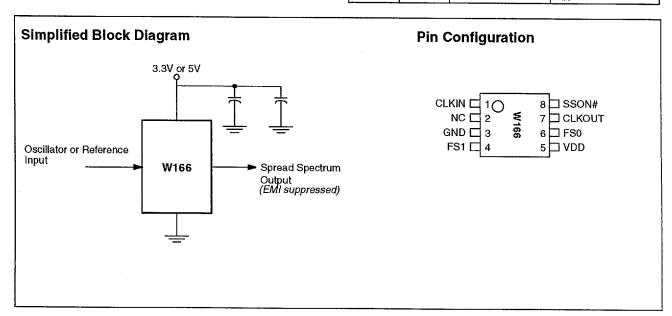
The W166 incorporates the latest advances in PLL spread spectrum frequency synthesizer techniques. By frequency modulating the output with a low-frequency carrier, peak EMI

is greatly reduced. Use of this technology allows systems to pass increasingly difficult EMI testing without resorting to costly shielding or redesign.

In a system, not only is EMI reduced in the various clock lines, but also in all signals which are synchronized to the clock. Therefore, the benefits of using this technology increase with the number of address and data lines in the system. The Simplified Block Diagram shows a simple implementation.

Table 1. Frequency Spread Selection

W	W166 Input				
FS1	FS0	Frequency (MHz)	Output Frequency (MHz)		
0	0	50 to 65	f _{IN} ±0.625%		
0	1	50 to 65	f _{IN} ±1.25%		
1	0	50 to 65	f _{IN} ±2.5%		
1	1	50 to 65	f _{IN} -3.75%		





Pin Definitions

Pin Name	Pin No.	Pin Type	Pin Description
CLKOUT	7	0	Output Modulated Frequency: Frequency modulated copy of the reference input (SSON# asserted).
CLKIN	1	1	External Reference Frequency Input: Clock input.
NC	2	NC	No Connect: This pin must be left unconnected.
SSON#	8	ı	Spread Spectrum Control (Active LOW): Asserting this signal (active LOW) turns the internal modulation waveform on. This pin has an internal pull-down resistor.
FS0:1	6, 4	1	Frequency Selection Bits 0,1: These pins select the frequency spreading characteristics. Refer to Table 1. These pins have internal pull-up resistors.
VDD	5	· Р	Power Connection: Connected to 3.3V or 5V power supply.
GND	3	G	Ground Connection: This should be connected to the common ground plane.

Functional Description

The W166 uses a Phase-Locked Loop (PLL) to frequency modulate an input clock. The result is an output clock whose frequency is slowly swept over a narrow band near the input signal. The basic circuit topology is shown in Figure 1. The input reference signal is divided by Q and fed to the phase detector. A signal from the VCO is divided by P and fed back to the phase detector also. The PLL will force the frequency of the VCO output signal to change until the divided output signal and the divided reference signal match at the phase detector input. The output frequency is then equal to the ratio of P/Q times the reference frequency. (Note: For the W166 the output frequency is equal to the input frequency.) The unique feature of the Spread Spectrum Frequency Timing Generator is that a modulating waveform is superimposed at the input to the VCO. This causes the VCO output to be slowly swept across a predetermined frequency band.

Because the modulating frequency is typically 1000 times slower than the fundamental clock, the spread spectrum process has little impact on system performance.

Frequency Selection With SSFTG

In Spread Spectrum Frequency Timing Generation, EMI reduction depends on the shape, modulation percentage, and frequency of the modulating waveform. While the shape and frequency of the modulating waveform are fixed, the modulation percentage may be varied.

A larger spreading percentage improves EMI reduction. However, large spread percentages may either exceed system maximum frequency ratings or lower the average frequency to a point where performance is affected. For these reasons, narrow and wide modulation selections are provided.

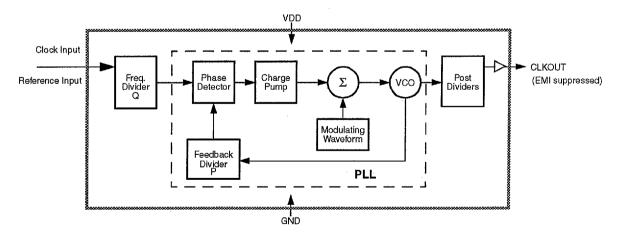


Figure 1. System Block Diagram



Spread Spectrum Frequency Timing Generator

The device generates a clock that is frequency modulated in order to increase the bandwidth that it occupies. By increasing the bandwidth of the fundamental and its harmonics, the amplitudes of the radiated electromagnetic emissions are reduced. This effect is depicted in *Figure 2*.

As shown in Figure 2, a harmonic of a modulated clock has a much lower amplitude than that of an unmodulated signal. The reduction in amplitude is dependent on the harmonic number and the frequency deviation or spread. The equation for the reduction is

 $dB = 6.5 + 9*log_{10}(P) + 9*log_{10}(F)$

Where P is the percentage of deviation and F is the frequency in MHz where the reduction is measured.

The output clock is modulated with a waveform depicted in Figure 3. This waveform, as discussed in "Spread Spectrum Clock Generation for the Reduction of Radiated Emissions" by Bush, Fessler, and Hardin produces the maximum reduction in the amplitude of radiated electromagnetic emissions. The deviation selected for this chip is ±0.45% or 0.6% of the selected frequency. Figure 3 details the Cypress spreading pattern. Cypress does offer options with more spread and greater EMI reduction. Contact your local Sales representative for details on these devices.

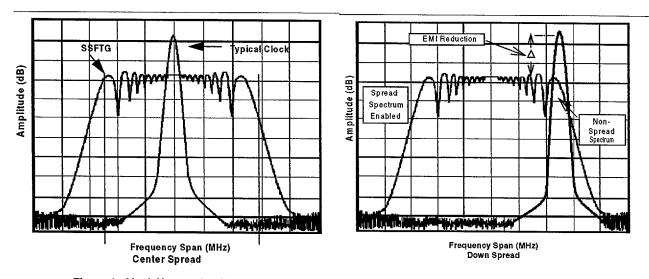


Figure 2. Clock Harmonic with and without SSCG Modulation Frequency Domain Representation

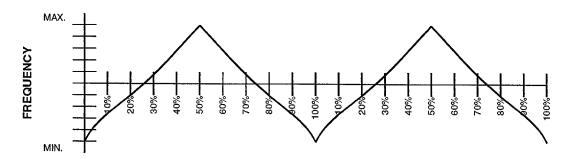


Figure 3. Typical Modulation Profile



Absolute Maximum Ratings

Stresses greater than those listed in this table may cause permanent damage to the device. These represent a stress rating only. Operation of the device at these or any other conditions

above those specified in the operating sections of this specification is not implied. Maximum conditions for extended periods may affect reliability

Parameter	Description	Rating	Unit
V _{DD} , V _{IN}	Voltage on any Pin with Respect to GND	-0.5 to +7.0	V
T _{STG}	Storage Temperature	-65 to +150	°C
T _A	Operating Temperature	0 to +70	°C
T _B	Ambient Temperature under Bias	-55 to +125	°C
P_{D}	Power Dissipation	0.5	W.

DC Electrical Characteristics: 0° C < T_{A} < 70° C, V_{DD} = 3.3V $\pm 5\%$

Parameter	Description	Test Condition	Min	Тур	Max	Unit
I _{DD}	Supply Current			18	32	mA
t _{ON}	Power Up Time	First locked clock cycle after Power Good			5	ms
V _{IL}	Input Low Voltage				0.8	V
V _{IH}	Input High Voltage		2.4			٧
Vol	Output Low Voltage				0.4	٧
V _{OH}	Output High Voltage		2.4			V
I _{IL}	Input Low Current	Note 1			-20	μА
I _{IH}	Input High Current	Note 1			20	μА
l _{OL}	Output Low Current	@ 0.4V, V _{DD} = 3.3V		15		mA
Гон	Output High Current	@ 2.4V, V _{DD} = 3.3V		15		mA
Cı	Input Capacitance	All pins except CLKIN			7	рF
CI	Input Capacitance	CLKIN pin only		6	5	pF
R _P	Input Pull-Up Resistor			500		kΩ
Z _{OUT}	Clock Output Impedance			25		Ω

Note:

^{1.} Inputs FS1:0 have a pull-up resistor, Input SSON# has a pull-down resistor.



DC Electrical Characteristics: 0° C < T_{A} < 70° C, V_{DD} = $5V \pm 10\%$

Parameter	Description	Test Condition	Min	Тур	Max	Unit
I _{DD}	Supply Current			21	40	mA
t _{ON}	Power Up Time	First locked clock cycle after Power Good			5	ms
V _{IL}	Input Low Voltage				0.8	V
V _{iH}	Input High Voltage		3.5			V
V _{OL}	Output Low Voltage				0.4	V
V _{OH}	Output High Voltage		2.4			V
l _{IL}	Input Low Current	Note 1			-20	μА
l _{IH}	Input High Current	Note 1			20	μА
l _{OL}	Output Low Current	@ 0.4V, V _{DD} = 5V		24		mA
l _{он}	Output High Current	@ 2.4V, V _{DD} = 5V		24	1	mA
CI	Input Capacitance	All pins except CLKIN	***************************************		7	pF
CI	Input Capacitance	CLKIN pin only			5	pF
R_P	Input Pull-Up Resistor			500		kΩ
Z _{OUT}	Clock Output Impedance		\	25		Ω

AC Electrical Characteristics: $T_A = 0$ °C to +70°C, $V_{DD} = 3.3 V \pm 5\%$ or $5V \pm 10\%$

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
f _{IN}	Input Frequency	Input Clock	50		65	MHz
f _{OUT}	Output Frequency	Spread Off	50		65	MHz
t _R	Output Rise Time 15-pF load, 0.8V-2.4V			2	5	ns
t _F	Output Fall Time	15-pF load, 2.4V-0.8V		2	5	ns
t _{OD}	Output Duty Cycle	15-pF load, test at V _{DD} /2	40		60	%
t _{ID}	Input Duty Cycle		40		60	%
t _{JCYC}	Jitter, Cycle-to-Cycle		*	250	300	ps
	Harmonic Reduction	f _{out} = 50 MHz, third harmonic measured, reference board, 15-pF load	8			dB



Application Information

Recommended Circuit Configuration

For optimum performance in system applications the power supply decoupling scheme shown in *Figure 4* should be used.

VDD decoupling is important to both reduce phase jitter and EMI radiation. The 0.1- μ F decoupling capacitor should be placed as close to the V_{DD} pin as possible, otherwise the in-

creased trace inductance will negate its decoupling capability. The 10- μF decoupling capacitor shown should be a tantalum type. For further EMI protection, the V_{DD} connection can be made via a ferrite bead, as shown.

Recommended Board Layout

Figure 5 shows a recommended a 2-layer board layout.

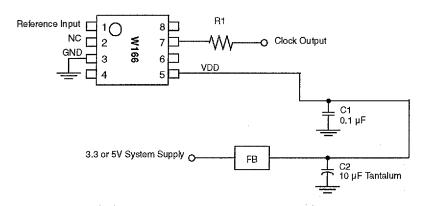


Figure 4. Recommended Circuit Configuration

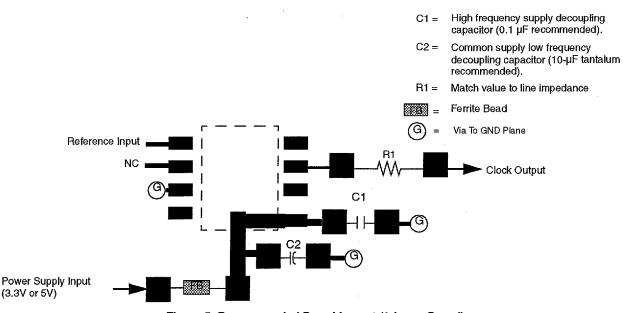


Figure 5. Recommended Board Layout (2-Layer Board)

Ordering Information

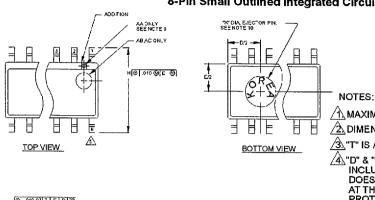
Ordering Code	Package Name	Package Type
W166	G	8-pin Plastic SOIC (150-mil)

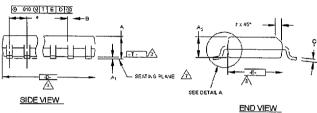
Document: #38-00878

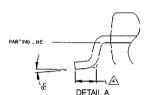


Package Diagram

8-Pin Small Outlined Integrated Circuit (SOIC, 150-mil)







DIMENSIONING & TOLERANCES PER ANSILY14.5M - 1982. "T" IS A REFERENCE DATUM. "D" & "E" ARE REFERENCE DATUMS AND DO NOT INCLUDE MOLD FLASH OR PROTRUSIONS, BUT DOES INCLUDE MOLD MISMATCH AND ARE MEASURED AT THE MOLD PARTING LINE. MOLD FLASH OR PROTRUSIONS SHALL NOT EXCEED 0.006 INCHES PER SIDE.

5 "L" IS THE LENGTH OF TERMINAL FOR SOLDERING TO A SUBSTRATE

6 "N" IS THE NUMBER OF TERMINAL POSITIONS.

ATERMINAL POSITIONS ARE SHOWN FOR

TERMINAL POSITIONS ARE SHOWN FOR REFERENCE ONLY.

8 FORMED LEADS SHALL BE PLANAR WITH RESPECT TO ONE ANOTHER WITHIN .003 INCHES AT SEATING PLANE.

9 THE APPEARANCE OF PIN #1 I.D ON THE 8 LD IS OPTIONAL, ROUND TYPE ON SINGLE LEADFRAME AND RECTANGULAR TYPE ON MATRIX LEADFRAME.

10, COUNTRY OF ORIGIN LOCATION AND EJECTOR PIN ON PACKAGE BOTTOM IS OPTIONAL AND DEPEND ON ASSEMBLY LOCATION.

THE TABLE KINDS

A CONTROLLING DIMENSION: INCHES

				1 -	IIS TABLE	IN INCH	iES		
s,	COMMON				NOTE		3		5
M		DIMENSIONS			VARI-		D		N
ابرا	MIN.	NOM.	MAX.	¹e	ATIONS	MIN.	NOM.	MAX.	
A	.061	.064	.068		AA	.189	.194	.196	8
A	.004	.006	.0098		ΑB	.337	.342	.344	14
A_2		.058	.061		AC	.386	.391	.393	16
В	.0138	.016	.0192		7.44				
C	.0075 .008 .0098								
D		VARIATION		3					
E	.150	.155	.157	1					'
е		.050 BSC							'
H	.230	.236	.244						
h	.010	.013	.016						Į .
L	.016	.025	.035						
Й	SEE VARIATIONS			5					}
α¢	0°	5°	8°						ļ
X	.085	.093	.100						-
									•

	THIS TABLE IN MILLIMETERS									
a V M	COMMON			L	NOTE 3					
18		<u>IMENSIOI</u>		No.	VARI-		D		N	
	MIN.	NOM.	MAX.	T _E	ATIONS	MIN.	NOM.	MAX.		
A	1.55	1.63	1.73		AA	4.80	4.93	4.98	8	
A,	0.127	0.15	0.25		AB	8.58	8.69	8.74	14	
A,	1.40	1.47	1.55		AC	9.80	9.93	9.98	16	
B	0.35	0.41	0.49	į			0.00	0.00	,-	
	0.19	0.20	0.25	1					l l	
D		VARIATION		3						
E	3,81	3.94	3.99							
е		1.27 BSC							ļ	
Η	5.84	5.99	6.20							
h	0.25	0.33	0.41							
L	0.41	0.64	0.89	ļ.						
И	N SEE VARIATIONS			5						
æ	0°	5°	8°							
X	2.16	2.36	2.54	Ī						

[©] Cypress Semiconductor Corporation, 1999. The information contained herein is subject to change without notice. Cypress Semiconductor Corporation assumes no responsibility for the use of dynamic and the support of the support systems application implies that the manufacturer assumes all risk of such use and in doing so indemnifies Cypress Semiconductor against all charges.